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# Photoluminiscent 1-2 nm Sized Silicon Nanoparticles: A Surface-2 Dependent System

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- Supporting Information

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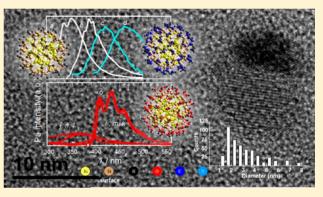
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ABSTRACT: The effect of derivatization and temperature on the photoluminescence of 1-2 nm size silicon particles of different origin is investigated in an attempt to understand the effect of surface on the particles' photoluminescence. To this purpose, silicon nanoparticles were synthesized by electrochemical (top-down) and wet chemical (bottom-up) procedures. Further derivatization by silylation or sylanization yielded particles with ≡Si-C≡, ≡Si-O-Si≡, and ≡Si-O-C≡ groups at the interface. A detailed analysis of the corresponding excitation-emission matrices strongly indicates that different surface atomic arrangements contribute to the energy gap. In particular, particles with ≡Si-O-Si≡ groups at the interface show photoluminescence independent of the



crystalline structure and on their further surface derivatization with different organic molecules. The lifetime and spectrum shape of all synthesized particles are invariable to changes in temperature in the range 270-330 K despite a significant reduction in the photoluminescence intensity being observed with increasing temperature; such behavior supports a thermal equilibrium between dark and bright conformations of the particles. The observed results are of importance for optimizing the use of silicon nanoparticles as optical sensors and therapeutic agents in biological systems.

**KEYWORDS:** surface states, thermal quenching, Si/SiO<sub>2</sub> interface, optical properties, surface chemistry

#### INTRODUCTION

30 Silicon nanoparticles of 1-5 nm size (SiNPs) have received 31 great attention as they combine photoluminescence emission 32 (PL) spanning the visible and near-IR spectral region, with the 33 capability for singlet oxygen (1O2) and superoxide (O2 •-) 34 generation.<sup>1,2</sup> Remarkable properties of nanostructured silicon 35 are their biocompatibility, biodegradability, and tunable surface 36 derivatization for drug delivery. 3,4 SiNPs surface derivatization 37 with active functional groups, biomolecules, and biocompatible 38 polymers is a key step in the development of their many 39 technological applications. An adequate selection of the surface 40 groups renders the particles' special properties as dispersibility 41 in the desired medium, surface protection against oxidation, 42 specific targeting, and opsonin association prevention.<sup>5</sup>

Work with SiNPs has shown that crystallinity, surface 44 structure, and surface chemistry play a role in their photo-45 physical behavior. Interpreting and classifying the large number 46 of energy gaps (EG) and Stokes shifts (SS) reported for SiNPs 47 is difficult due to long-standing divergences in the synthesis of 48 monodisperse samples with well-characterized surfaces, as a 49 variety of groups (e.g.,  $\equiv$ Si $\rightarrow$ OH, >Si $\equiv$ O,  $\equiv$ Si $\rightarrow$ O $\rightarrow$ Si $\equiv$ ,

≡Si—H, ≡Si—C≡, etc.) present in different proportions 50 may form the interface of the designed product. In fact, the 51 fundamental photophysics of SiNPs is not currently as well 52 understood as that of direct gap semiconductors such as CdSe. 6 53

Electron density functional theory assuming finite barrier for 54 the potential confinement applied to H-saturated silicon 55 clusters predicts smooth variations of the EG with size.<sup>7</sup> 56 Increased EG observed experimentally for crystalline clusters 57 were suggested to be a consequence of symmetry and reduced 58 angular distortion in the Si-Si bonds. These authors 59 predicted that localization of the HOMO and the LUMO 60 occurred throughout the core for unreconstructed surfaces 61 (e.g., Si<sub>35</sub>H<sub>36</sub> bulk surface) whereas localization at the surface 62 was observed for reconstructed surfaces (e.g., Si<sub>29</sub>H<sub>24</sub>). 63 Moreover, experimental and computational work with SiNPs 64 demonstrated the fundamental importance of surface chemistry 65 in dictating their photophysical behavior.<sup>6,9,10</sup> In particular, 66

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67 single bonded Si—OH and Si—O—Si groups on Si<sub>29</sub> and Si<sub>47</sub>
68 cores have relatively slight influences on the band edges and
69 gap, whereas double bonded Si=O surface structures
70 significantly affect them. The increase in surface coverage
71 causes a further change of the EG.<sup>9</sup> More recent studies suggest
72 that Si—O—Si structures on the curved surface of <3 nm size
73 SiNPs, but not on the facet of >3–4 nm particles, lead to
74 localized levels in the EG. As a consequence, a red-shift in the
75 PL spectra of small oxidized SiNPs is observed.<sup>11</sup>

The temperature dependence of the PL of SiNPs is suggested to be an intrinsic property of the particles strongly 8 depending on size. SiNPs from different synthesis routes 9 are reported to show increased PL intensity with decreasing 80 temperature until ca. 60-80 K. A further decrease in 1 temperature rapidly diminishes the PL intensity along with an 1 terms of the competition between temperature-dependent 1 radiative  $(k_r)$  and nonradiative  $(\sum_i k_{ni})$  decay rates of the highly 1 localized excitons, as those provided by defects in the 1 nanocrystal or at the Si/SiO<sub>2</sub> interface.

Herein we investigate the effect of surface derivatization and temperature on the PL of SiNPs of different origin in an attempt to understand the effect of surface on the particles PL. This knowledge is necessary for optimizing the use of SiNPs as optical sensors and therapeutic agents in biological systems. To that purpose, SiNPs were synthesized by electrochemical (top-30 down, TD) and wet chemical procedures (bottom-up, BU), and further derivatized by silylation or sylanization to yield particles with  $-NH_2$  terminal groups and different chemistry at the interface ( $\equiv$ Si $-C\equiv$ ,  $\equiv$ Si $-O-Si\equiv$ , and/or  $\equiv$ Si $-O-C\equiv$ ).

## 98 EXPERIMENTAL SECTION

Materials. Toluene (99.7%,  $H_2O$  0.005%), methyl 2-methylprop-2-100 enoate, methanol, cyclohexane, 9,10- diphenylanthracene, LiAl $H_4$  101 (95%), SiC $I_4$  (99%), ethyl ether (p.a. 99.9%), tetraoctylammonium 102 bromide (98%), (3-aminopropyl)triethoxysilane, and 2-propen 1-103 amine were purchased from Sigma-Aldrich and employed without 104 further purification. Deionized water (>18  $M\Omega$  cm, <20 ppb of organic 105 carbon) was obtained with a Millipore system. Nitrogen (4 bands 106 quality) and oxygen gas were both from La Oxígena S.A., Argentina.

Equipment. FTIR spectra were obtained with a Bruker EQUINOX 108 spectrometer. Either KBr disks or silicon wafers were used as holders. 109 Spectra were taken in the 4000–400 cm<sup>-1</sup> range with 1 cm<sup>-1</sup> 110 resolution. Attenuated total reflection infrared (ATR-IR) spectroscopy 111 used for the analysis of the surface of derivatized particles was 112 performed with a Nicolet 380 FTIR ATR accessory using a ZnSe 113 crystal and an incident beam angle of 45°.

The attenuance spectra were recorded with a double-beam 115 Shimadzu UV-1800 spectrophotometer in a 1 cm quartz cuvette at a 116 scan rate of 300 nm/min. The nanoparticle light scattering is 117 calculated by fitting the 450–800 nm range attenuance to a  $a \times \lambda^{-4}$ 118 dependence. The corrected absorbance spectrum is obtained by 119 subtraction of the scattering from the measured attenuance spectrum. PL measurements were performed with a Jobin-Yvon Spex 121 Fluorolog FL3-11 spectrometer. The fluorimeter is equipped with a 122 Xe lamp as the excitation source, a monochromator with 1 nm 123 bandpass gap for selecting the excitation and emission wavelengths, 124 and a red sensitive R928 p.m. as detector. All spectra were corrected 125 for the wavelength-dependent sensitivity of the detector and the 126 source. Additionally, emission spectra were corrected for Raman scattering by using the solvent emission spectrum. To estimate the emission quantum yield  $(\Phi)$ , emission spectra were collected at 129 various excitation wavelengths. Identical measurements (excitation 130 conditions, lamp energy, and spectrometer band-pass) were performed 131 on 9,10-diphenylanthracene in cyclohexane. 2,15,16 The temperature was controlled to  $\pm 0.1$  °C with an F-3004 Peltier sample cooler 132 controlled by a LFI-3751 temperature controller (Wavelength 133 electronics).

Time-resolved PL measurements were performed with either a 135 Jobin-Yvon Spex Fluorolog FL3-11 spectrometer (vide supra) 136 equipped with TCSPC with LED excitation at 341 and 388 nm 137 (fwhm ~ 400 ps) or a mode-locked Ti:Sapphire laser (Spectra Physics, 138 Millennia-pumped Tsunami) with a 130-fs pulse duration operating at 139 80 MHz. The laser output was sent through a frequency doubler and  $^{140}$ pulse selector (Spectra Physics Model 3980) to obtain 370-450 nm 141 pulses at 4 MHz. Fluorescence emission was detected at the magic 142 angle using a double grating monochromator (Jobin Yvon Gemini- 143 180) and a microchannel plate PMT (Hamamatsu R3809U-50). The 144 instrument response function was 35-55 ps. Data was acquired by a 145 Becker-Hickl SPC-830 card. Temperature was controlled to ±0.1 °C 146 with an Oxford Optistat DN liquid nitrogen-cooled optical cryostat 147 equipped with an Oxford ITC 601 controller. Data was globally fitted 148 as sum of exponentials including IRF deconvolution until optimal 149 values of  $\chi^2$ , residuals, and standard deviation parameters were 150 attained.

TEM micrographs were taken with a JEOL 2010 F microscope 152 using a carbon-coated 300-mesh copper grid. Images were analyzed 153 employing the Image Tool 3.0 software (Health Science Center of the 154 University of Texas, San Antonio, TX, USA). Particle diameters were 155 determined assuming that the particle area obtained from the TEM 156 images is the projection of a spherical particle. A log-normal function 157 was found to best describe the size distribution of the 500 particles 158 sample.

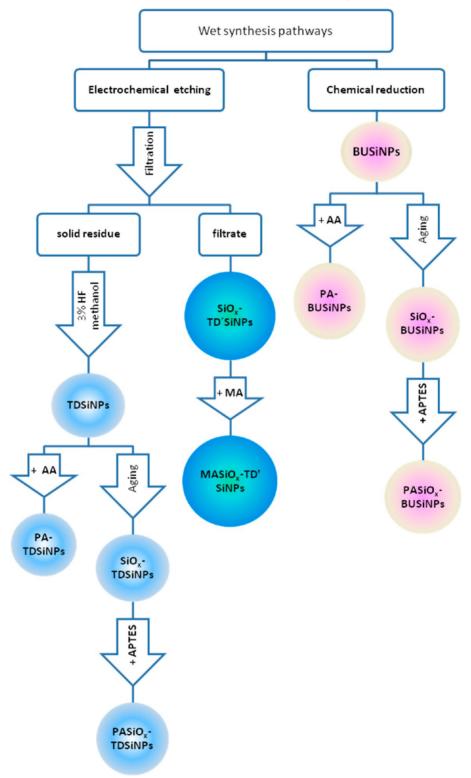
The X-ray photoelectron spectroscopy (XPS) spectra were obtained 160 under UHV with a XR50 Specs GmbH spectrometer with Mg K $\alpha$  as 161 the excitation source and a PHOIBOS 100 half sphere energy analyzer. 162 Internal calibration was performed with Au  $4f_{7/2}$  (binding energy, BE, 163 84.00 eV) and with the C 1s peak at BE = 284.6 eV due to adventitious 164 carbon. Also, to get a better insight into the chemical environment of 165 the different atoms, high resolution XPS spectra were taken and 166 resolved by Gaussian—Lorentzian fitting, keeping  $\chi^2$  values between 1 167 and 1.25.

Bilinear Regression Analysis. For low fluorophore absorbance 169 (<0.05), the steady state emission intensity at the given emission 170 wavelength,  $I(\lambda_{em})$ , is proportional to the absorption coefficient of the 171 fluorophore at the excitation wavelength,  $arepsilon(\lambda_{
m ex})$ , the concentration of 172 the fluorophore, and a factor  $F(\lambda_{
m em})$  reflecting the shape of the 173 emission spectrum. The bilinear regression analysis takes advantage of 174 the linearity of  $I(\lambda_{\rm em})$  with both  $\varepsilon(\lambda_{\rm ex})$  and  $F(\lambda_{\rm em})$  to retrieve 175 information from the experimental excitation-emission matrix on the 176 minimum number of species and on their relative emission and 177 absorption spectra. 16 It should be noted that the recovery of the 178 excitation-emission spectrum of all the individual components from a 179 bilinear analysis of a multicomponent system is not always possible in 180 those cases where the emission and excitation spectra of the different 181 species are strongly superimposed.<sup>17</sup> A further disadvantage is a low 182 contribution of one of the species to the overall emission. In these 183 cases, the different components may not be differentiated by a bilinear 184 analysis, and the individual recovered species are rather a family of 185 strongly optically related compounds.

SiNPs Synthesis. TD approaches involved an adaptation of the 187 electrochemical method with HF etching of porous Si. Briefly, clean 188 crystalline Si wafers (p-type, with resistivity between 1.0 and 10.0  $\Omega$  189 cm) were electrochemically etched (20 mA electrical current) in a 190 Teflon cell containing the electrolytic solution (16% HF, 16% CH<sub>3</sub>OH 191 v/v). After anodization, the wafer was rinsed with methanol and 192 toluene, further immersed in Ar-saturated toluene, and Si-NP released 193 by immersion in an ultrasound bath for 2 h (Ney Dental Inc.; 50/60 194 Hz; 100 W). The resulting suspension was purified by filtration 195 through hydrophilic 100 nm PVDF membrane filters (MILLEX-HV, 196 Millipore), and both the solid residue and the filtrate were separated to 197 obtain different SiNPs.

The solid residue was suspended in a 3% HF methanol solution, 199 sonicated, and stored in the dark for two hours to break up and etch 200 agglomerates.  $^{18}$  After water addition, the well-dispersed aqueous 201

Scheme 1. Summary Flow Chart on the Synthesis Pathways Followed for Obtaining the Different SiNPs<sup>a</sup>



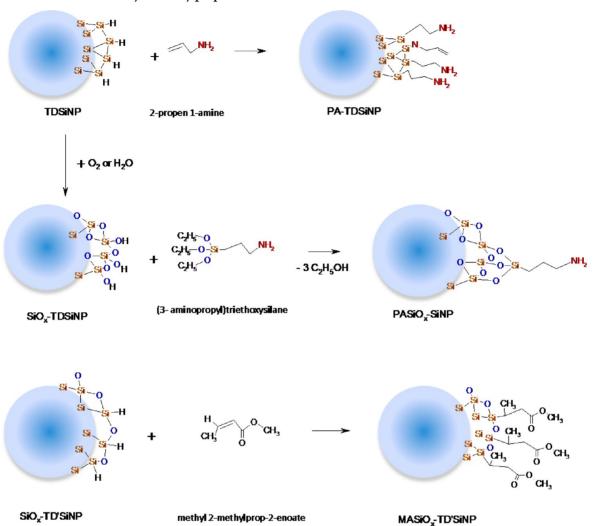
"AA, MA, and APTES stand for 2-propen 1-amine, methyl 2-methylprop-2-enoate, and (3- aminopropyl)triethoxysilane, respectively.

202 suspension of SiNPs was shaken with cyclohexane to extract the 203 hydrophobic nanoparticles with H-passivated surfaces to the organic 204 phase. The solvent was evaporated and the remaining silicon particles 205 dispersed in toluene for further use. The "as obtained" particles will be 206 referred to as TDSiNPs. When required, TDSiNPs were allowed to 207 age upon standing in an air-saturated suspension in the dark for several 208 weeks, leading to the formation of surface-oxidized particles, SiO<sub>x</sub>-

TDSiNPs. Surface-oxidized 3 nm size SiNPs with a  $SiO_x$  layer and 209 Si—H surface functionalities are obtained from the filtrated 210 suspension. Because of their common TD synthetic procedure, 211 these particles are referred to as  $SiO_x$ -TD'SiNPs.

The BU-approach synthesis involved an adaptation of the LiAlH $_4$   $_{213}$  reduction of SiCl $_4$  in the presence of tetraoctylammonium bromide  $_{214}$  reversed micelles.  $^{16}$  Freshly prepared particles showing H- and Cl-  $_{215}$ 

Scheme 2. Surface Composition of TDSiNPs Derivatized with 2-Propen 1-Amine and (3- Aminopropyl)triethoxysilane and TD'SiNPs derivatized with Methyl 2-Methylprop-2-enoate<sup>a</sup>



<sup>a</sup>The blue circles stand for the silicon core of the particles.

216 passivated surfaces are named BUSiNPs. These surface groups are 217 oxidized to Si—OH during storage under air-saturation for two weeks, 218 as confirmed by the appearance of a broad band near 3400 cm<sup>-1</sup> in the 219 FTIR spectrum, characteristic of Si—O—H stretching vibration. Aged 220 particles are denoted as SiO<sub>x</sub>-BUSiNPs.

Surface Derivatization. SiNPs were capped with organic molecules either by photoinitiated silylation or by thermal silanization. The silylation process involved mixing of a colloid dispersion of either fresh TDSiNPs or BUSiNPs in toluene with microliter quantities of 2-propen 1-amine (reactant in defect). The resulting suspension was irradiated for 5 h with 254 nm light from eight Rayonet Lamps (RPR2537A, Southerm N.E. UltravioletCo.) to yield PA-TDSiNPs and PA-BUSiNPs. A similar procedure using 350 nm light from a Rayonet Lamp (RPR3500A, Southerm N.E. UltravioletCo.) was applied for freshly prepared methyl 2-methylprop-2-enoate derivatized SiO<sub>x</sub>-TD'SiNPs containing surface Si—H bonds (MASiO<sub>x</sub>-TD'SiNPs).

The silanization procedure involved coupling of (3-aminopropyl)triethoxysilane to terminal Si—OH groups. Therefore, suspended
surface-oxidized BUSiNP and TDSiNP in toluene were treated with
(3-aminopropyl)triethoxysilane and stirred at room temperature for 24
h. Removal of excess organosilane and tetraoctylammonium bromide
was achieved by membrane dialysis. Oxidized particles derivatized with
kan achieved by membrane dialysis. Oxidized particles derivatized with
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For clarity, a flowchart summary depicting the synthesis pathways is 240 given in Scheme 1. 241 s1

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## ■ RESULTS AND DISCUSSION

Silicon nanoparticles were obtained in the laboratory by top- 243 down (TD) and bottom-up (BU) approaches, yielding H- 244 passivated crystalline TDSiNPs and amorphous BUSiNPs with 245 Si—H and Si—Cl surface groups, respectively (vide supra). 246 These particles were either derivatized to cover the surface with 247 propylamine terminal groups to yield PA-TDSiNPs and PA- 248 BUSiNPs or allowed to age to yield surface oxidized SiO<sub>x</sub>- 249 TDSiNPs and SiO<sub>x</sub>-BUSiNPs. The latter particles were further 250 derivatized to yield propylamine-terminated PASiO<sub>x</sub>-TDSiNPs 251 and PASiO<sub>x</sub>-BUSiNPs, respectively. SiO<sub>x</sub>-TD'SiNPs particles 252 were obtained by a modification of the TD approach involving 253 the simultaneous oxidation and etching of porous silicon. They 254 differ from SiO<sub>x</sub>-TDSiNPs in that they present Si-H, Si-255 O—Si, and Si—OH structures in their surface. SiO<sub>x</sub>-TD'SiNPs 256 particles were further derivatized to yield methyl 1-methyl- 257 propanoate-terminated MASiO<sub>x</sub>-TD'SiNPs. Scheme 2 summa- 258 s2 rizes the derivatization reactions for TDSiNPs and shows the 259 average surface composition of the particles.

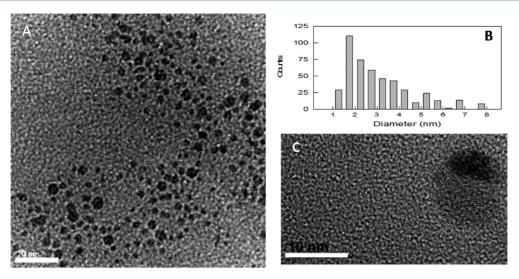


Figure 1. (A) TEM image of TDSiNPs, (B) associated size histogram of 500 non-touching particles, and (C) HRTEM micrograph of agglomerated particles showing silicon d<sub>111</sub> crystalline planes.

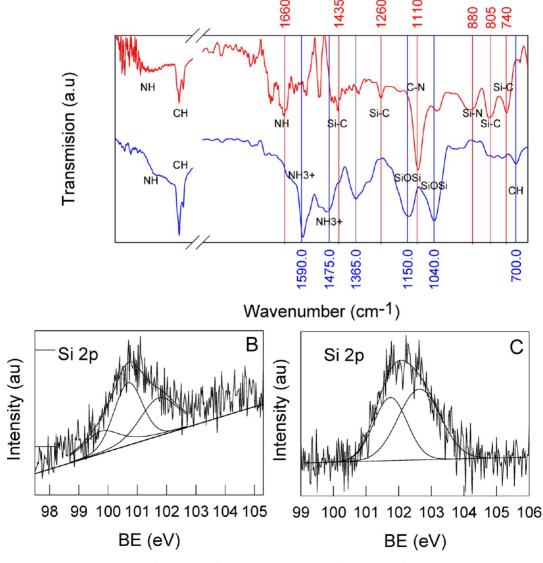


Figure 2. (A) FTIR spectra of PA-TDSiNPs (red spectrum) and PASiO<sub>x</sub>-TDSiNPs (blue spectrum), deposited from toluene suspensions on Si wafer supports. The vertical solid lines stand as guides to the eye for the peak positions. (B) and (C) stand for the high resolution Si 2p XPS peak of PA-TDSiNPs and PA-SiO<sub>x</sub>TDSiNPs, respectively.

**Particle Characterization.** An average size of 1.8 nm with 262 a high dispersion toward bigger sizes is observed for TDSiNPs 263 from the size histogram, as shown in Figure 1A,B. However, a 264 thorough analysis of the micrographs (Figure 1C) indicates 265 important particle agglomeration. In fact, atomic force 266 microscopy performed on mercaptopropyl-derivatized 267 TDSiNPs after drop-casting on a mica support and the heights 268 extracted from scanning tunneling microscopy topography of 269 mercaptopropyl-terminated TDSiNPs on a Au(111) substrate 270 show size histograms indicating highly monodispersed samples 271 with a mean particle height of  $(1.7 \pm 0.3)$  and around  $(1.6 \pm 272 \ 0.5)$  nm, respectively.<sup>20</sup> The image in Figure 1C and other 273 HRTEM micrographs shown in S.I. Characterization (Support-274 ing Information) clearly show Si crystalline planes with lattice 275 spacing of 3.1  $\pm$  0.1 Å, in agreement with that reported for the 276 d<sub>111</sub> plane of SiNPs. <sup>21,22</sup> On the other hand, aged BUSiNPs 277 showed an average particle size of  $(1.7 \pm 0.8)$  nm and no 278 evidence of a crystalline structure could be found 6 (see also 279 TEM micrographs in S.I. Characterization, Supporting 280 Information).

The analysis of the XPS and IR spectra of the different 282 particles allows the determination of the average surface 283 composition. Figure 2A, top spectrum, shows the FTIR 284 spectrum of PA-TDSiNPs. The observed N-H vibrations in 285 the 3400 (weak), 1650–1580, and 910–665 cm<sup>-1</sup> regions are 286 characteristic of primary and secondary amines. The C-N 287 stretching vibration of aliphatic amines is observed at 1260 cm<sup>-1</sup>. The presence of bands at 1435, 1270, 805, and 740 cm<sup>-1</sup> 289 due to Si-C symmetric and asymmetric deformation, 290 stretching, and CH2 rocking in Si-CH2 respectively, as well 291 as peaks in the 2970-2880 cm<sup>-1</sup> region due to CH<sub>2</sub> stretching 292 and bending, confirm PA bonding to TDSiNPs.<sup>23,24</sup> The corresponding XPS spectrum shows Si 2p signals, Figure 2B, at 99.70 (10%), 100.7 (57%), and 101.8 eV (33%), characteristic of Si<sup>0</sup>, Si—C, and Si—N environments, respectively.<sup>25-27</sup> The N 1s signal may be described by a main peak at 399.4 eV characteristic of C-NH<sub>2</sub> groups. No significant contribution due to N in Si environments (peak at 398 eV<sup>27</sup>) is observed. 299 However, the FTIR absorption at 880 cm<sup>-1</sup> could be assigned 300 to the presence of Si—N vibrations.<sup>28</sup> N-bonding to Si may be 301 a secondary product of the radical mechanism involved in the 302 synthesis reaction, as described in S.I. Scheme 1 (Supporting 303 Information).

The FTIR spectra of PASiO<sub>x</sub>-TDSiNPs, see bottom 305 spectrum in Figure 2A, shows intense bands at 1150 and 306 1040 cm<sup>-1</sup> characteristic of Si—O—Si in different environments, thus denoting surface-oxidized particles. Absorption bands in the region  $1550-1450~\text{cm}^{-1}$  may be assigned to N-H vibrations in protonated amines.<sup>29</sup> The peak at  $1332~\text{cm}^{-1}$  is 310 assigned to CO<sub>2</sub> trapped by surface NH<sub>3</sub><sup>+</sup> in coincidence with 311 that reported for protonated (3-aminopropyl)triethoxysilane 312 films.<sup>30</sup> On the other hand, the Si 2p XPS peak displays the 313 contribution of silicon environments with binding energies of 314 101.7 and 102.6 eV which may be assigned to Si(O—)2 and 315 Si(O-)<sub>3</sub>-C environments, 31,32 in agreement with the 316 expected PASiO<sub>x</sub>-TDSiNPs surface depicted in Scheme 2. N 317 1s peaks at 399.4 eV may be assigned to C-NH<sub>2</sub> 318 environments, and the IR peaks due to CH2 stretching and 319 bending vibrations in the 2970-2880 cm<sup>-1</sup> and 1465-1440 320 cm<sup>-1</sup> region further support the covalent link of organic 321 moieties to the silicon framework. The absence of Si 2p XPS 322 peaks around 104 eV and IR bands around 1250 cm<sup>-1</sup> due to

Si=O in bulk SiO<sub>2</sub> supports the negligible formation of SiO<sub>2</sub> 323 structures. <sup>33</sup>

Ratios between Si, O, C, and N signals in the XPS spectrum  $^{325}$  corrected for the instrument sensitivity yield the average surface  $^{326}$  composition for the different SiNPs, as shown in Table 1 and in  $^{327}$  to

Table 1. Average Size and Surface Composition of Solid Samples Obtained from the Different Synthesis and Derivatization Procedures<sup>a</sup>

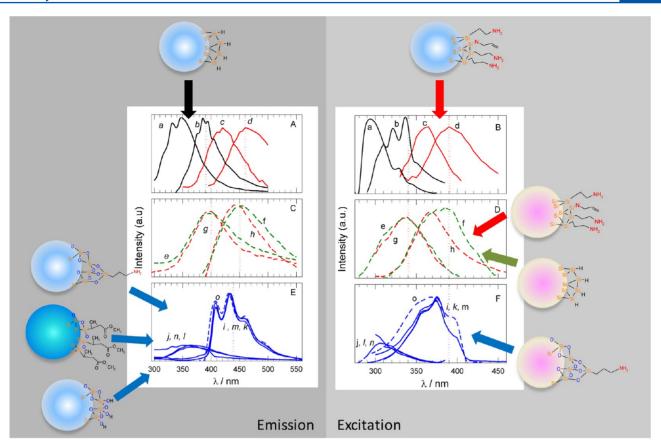
particle	size, nm	average surface composition <sup>b</sup>
TDSiNPs	$1.7 \pm 0.3$	
PA-TDSiNPs	$1.7 \pm 0.3$	$Si_2C_5N_{4.4}H_y$
SiO <sub>x</sub> -TDSiNPs	$1.7 \pm 0.3$	
PASiO <sub>x</sub> -TDSiNPs	$1.7 \pm 0.3$	$Si_{12}C_{3.5}H_yN_1O_x$
MASiO <sub>x</sub> -TD'SiNPs	$3 \pm 1^c$	$Si_3O_6(C_5O_2H_y)_1^c$
BUSiNPs	$1.7 \pm 0.8$	
PA-BUSiNPs	$1.7 \pm 0.8$	
SiO <sub>x</sub> -BUSiNPs	$1.7 \pm 0.8$	$Si_{4.2}O_{3.8}ClH_y$
PASiO <sub>x</sub> -BUSiNPs	$1.7 \pm 0.8$	

<sup>a</sup>Surface oxidized particles are in bold. <sup>b</sup>H "y" proportion was not determined though observed. <sup>c</sup>Data from ref 1.

agreement with the expected surface structures depicted in 328 Scheme 2. FTIR and XPS characterization of BUSiNPs, PA- 329 BUSiNPs, SiO $_x$ -BUSiNPs, and PASiO $_x$ -BUSiNPs also supports 330 the expected surface structure, in agreement with the FTIR and 331 XPS peak assignations observed for TDSiNPs derivatives. For 332 further details refer to S.I. Characterization (Supporting 333 Information). It should be recalled that PA-TDSiNPs also 334 shows a small FTIR absorption at 850 cm $^{-1}$  and peak 335 contributions to the Si 2p band at 101.5 and 102.2 eV, 336 characteristic of Si( $C_xN_y$ ) and Si—N environments. <sup>25,28</sup> In 337 conclusion, PA derivatization of H-passivated SiNPs by a 338 photoinitiated radical mechanism leads invariably to N-bonding 339 to Si independently of the crystalline structure of the silicon 340 network.

Photoluminescence Experiments. The PL of the differ- 342 ent particles in Ar-saturated toluene suspensions shows 343 particular features strongly depending on surface groups and 344 synthesis procedures. Moreover, the dependence of the 345 emission spectrum with the excitation wavelength for a given 346 suspension indicates the contribution of particles of different 347 size, morphology, surface chemistry, and/or oxidation grade 348 within the sample. The contribution of different emitters to 349 the overall excitation—emission matrix was analyzed on the 350 assumption that single chromophores existing in a unique form 351 show excitation wavelength-invariant emission spectrum. Size Figure 3 shows the emission and excitation spectra of 353 for contributing emitters as obtained from the bilinear analysis of 354 the excitation—emission matrix of argon-saturated toluene 355 suspensions of the different synthesized particles.

Decay times ( $\tau$ ) and quantum yields at 298 K ( $\Phi^{298\text{K}}$ ) were 357 measured at selected excitation and emission wavelengths to 358 focus on a particular contributing emitting species. Measured  $\tau$  359 values for TDSiNPs and BUSiNPs and their surface-function-360 alized derivatives are within 1–7 ns, as depicted in Table 2. 361 t2 Under conditions of low excitation power density, the excited 362 states of the particles decay unimolecularly and the PL quantum 363 yield is  $\Phi = k_{\text{r}}/(k_{\text{r}} + \sum_i k_{\text{n}i})$ , where  $k_{\text{r}}$  stands for the radiative 364 decay rate and  $\sum_i k_{\text{n}i}$  for nonradiative processes. Therefore, 365 considering the luminescence lifetime  $\tau = (k_{\text{r}} + \sum_i k_{\text{n}i})^{-1}$ , the 366 product  $\Phi \times \tau^{-1}$  yields  $k_{\text{r}}$ . Considering the data in Table 2, 367



**Figure 3.** Emission (A, C, and E) and excitation (B, D, and F) spectra at 313 K of argon-saturated toluene suspensions of contributing emitters as obtained from the bilinear analysis of the excitation—emission matrix of TDSiNPs (a and b, black solid lines), PA-TDSiNPs (c and d, red solid lines), BUSiNPs (e and f, green dashed lines), PA-BUSiNPs (g and h, red dashed lines), SiO<sub>x</sub>-TDSiNPs (i and j, blue solid lines), PASiO<sub>x</sub>-TDSiNPs (k and l, blue solid lines), MASiO<sub>x</sub>-TDSiNPs (m and n, blue solid lines), and PASiO<sub>x</sub>-BUSiNPs (o, blue dashed lines). The vertical lines stand for the excitation (B, D, and F) and detection (A, C, and E) wavelengths in time-resolved experiments.

Table 2. Energy gap (EG), maximum emission ( $\lambda_{\rm em}^{\rm max}$ ), Stokes shifts (SS), decay times ( $\tau$ ), and quantum yields ( $\Phi$ ) of the different emitting particles obtained at 298 K in argon-saturated suspensions<sup>a</sup>

particle	emitter	EG (±0.05), eV	$\lambda_{\mathrm{em}}^{\mathrm{max}}$ , eV	SS (±0.05), eV	$\tau(\%)$ , ns	$\Phi^{298K}$ (±0.05)
TDSiNPs	а	3.4	3.4	0.67	0.5 (76)	0.2 (air: 0.005
	b	3.15	3.1	0.53	3.15 (19)	0.19
PA-TDSiNPs	с	3.0	2.95	0.49	$1.6 \pm 0.1 (70)$	0.16
	d	2.7	2.7	0.50	$4.3 \pm 0.1 (27)$	0.2 (air: 0.14)
SiO <sub>x</sub> -TDSiNPs	i	3.0	3.0	0.45	$1.27 \pm 0.05$	0.13
	j	3.4	3.5	0.59		
PA-SiO <sub>x</sub> -TDSiNPs	k	3.0	3.0	0.45	$1.30 \pm 0.05$	0.36
	1	3.4	3.4	0.60		0.3
MASiO <sub>x</sub> -TD'SiNPs <sup>b</sup>	m	3.0	2.85	0.43	$1.19 \pm 0.05$	0.76 (air:0.44
	n	3.3	3.4	0.62		
BUSiNPs e	e	3.1	3.1	0.55	$1.5 \pm 0.5$	
	f	2.8	2.8	0.45	$7 \pm 0.5$	
PA-BUSiNPs g h	g	3.15	3.1	0.56	$1.2 \pm 0.3 (80)$	0.25
	h	2.65	2.75	0.63	$4.5 \pm 0.1 (20)$	0.34
SiO <sub>x</sub> -BUSiNPs <sup>b</sup>		3.0	2.85	0.45	$1.6 \pm 0.05$	
PASiO <sub>x</sub> -BUSiNPs	o	2.95	2.85	0.44	$1.1 \pm 0.1$	0.1

<sup>&</sup>lt;sup>a</sup>Depicted Φ are lower limit values, see text. Values in bold stand for surface oxidized particles. <sup>b</sup>Data from ref 16.

 $_{368}$  expected  $k_{\rm r}$  values fall within  $(1-60) \times 10^7~{\rm s}^{-1}$ . However, as it  $_{369}$  will be discussed later,  $\Phi$  values also consider the absorbance of  $_{370}$  dark particles, and therefore calculated  $k_{\rm r}$  values are lower limit  $_{371}$  estimations.

The mean energy gap (EG) of charge carriers in silicon an anoparticles may be evaluated using the excitation spectrum

(PLE) threshold of each individual species. <sup>16,34</sup> Calculated EG <sub>374</sub> values for each emitting species, shown in Table 2, coincide <sub>375</sub> with the PL maxima, strongly supporting that the excitation and <sub>376</sub> the emission mainly originate from the same transition. <sub>377</sub> Corresponding Stokes shifts (SS), also shown in Table 2, <sub>378</sub> vary within the 0.4–0.6 eV range.

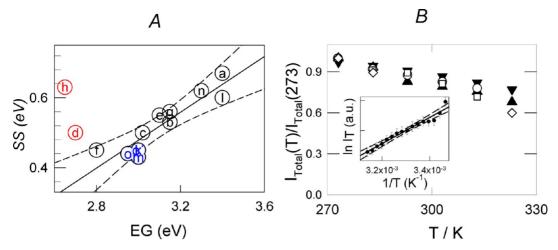


Figure 4. (A) Stokes distance dependence with the energy gap. The letters inside the symbols stand for the different emitting species. (B) Ratio of the total emission intensity at a given temperature to that observed at 273 K  $(I_T(T)/I_T(273))$  for argon-saturated toluene suspensions of species a ( $\nabla$ ), b ( $\triangle$ ), c ( $\diamondsuit$ ), k ( $\bigcirc$ ), and m ( $\square$ ) vs T. Inset: ln  $I_T$  vs  $T^{-1}$  for argon-saturated toluene suspensions of species k.

The PL of TDSiNPs suspensions shows the contribution of two emitting species (a and b in Figure 3A,B). The observed wide PL bands (fwhm of about  $\Delta E \approx 400 \text{ meV}$ ) extending over the 350-450 nm range and decay lifetimes in the nanosecond regime are in agreement with those reported for 1 nm size SiNPs.<sup>8,9,35</sup> On the assumption that the observed luminescence 386 is controlled by quantum confinement, particle sizes of 1.3–1.6 387 nm are estimated from theoretical correlations of the EG with size reported for H-terminated crystalline SiNPs,<sup>7</sup> in line with experimentally determined values (vide supra). The PL of PA-TDSiNPs also shows two contributing species (c and d in Figure 3A,B) with red-shifted PL compared to those of *a* and *b*. 391 Since PA-TDSiNPs and TDSiNPs mainly differ in their surface composition ( $\equiv$ Si-CH<sub>2</sub>-CH<sub>2</sub>-CH<sub>2</sub>-NH<sub>2</sub> and  $\equiv$ Si-NH- $CH_2$ —CH= $CH_2$  surface groups in place of  $\equiv Si$ —H), the observed differences in their excitation-emission matrix may only be attributed to the strong dependence of the PL on the surface chemical composition. Recent theoretical and experimental studies indicate that coverage of SiNPs with alkylgroups (Si-C) results in a minimal change in PL spectra. 400 Since SiNPs with Si-N terminations exhibit significant PL 401 shifts compared to H-passivated SiNPs, 27,36 the observed 402 differences may be attributed to Si—N surface bonds.

On the other hand, the PL and PLE spectra of amorphous 404 BUSiNPs (e and f in Figure 3C,D) are shifted to the red with 405 respect to those of crystalline TDSiNPs, as expected from 406 theoretical calculations for amorphous<sup>37</sup> and crystalline<sup>7</sup> 407 particles of similar size. It has been recently reported<sup>27</sup> that 408 H-passivated SiNPs exposed to the surfactant tetraoctylammonium bromide yield PL spectra in the 400 and 450 nm range as 410 a consequence of the formation of Si-N surface bonds. Since 411 no evidence on the formation of Si-N environments was 412 obtained from XPS and FTIR data of BUSiNPs, 16 tetraocty-413 lammonium bromide chemisorption to the particle surface is of 414 no significance under our synthesis conditions. In fact, the PL 415 of species e and f is coincident to that reported for 1.5 nm-size 416 amorphous SiNPs obtained from the electrochemical etching of 417 amorphous Si films.<sup>38</sup> The excitation-emission matrix of 418 propylamine-surface derivatized BUSiNPs shows the contribu-419 tion of two emitting species (g and h in Figure 3C,D) with 420 similar PL and PLE spectra to those of species e and f. Thus, 421 Si—C and Si—N environments confining BUSiNPs appears

not to significantly affect the overall density of states within the 422 capture volume of spatially confined carriers leading to PL in 423 amorphous SiNPs. 424

Surface oxidized particles of diverse origin (TD and BU 425 synthesis) and with different capping groups, mainly SiO<sub>x</sub>- 426 TDSiNPs, PASiO<sub>x</sub>-TDSiNPs, SiO<sub>x</sub>-TD'SiNPs, MASiO<sub>x</sub>- 427 TD'SiNPs, SiO<sub>x</sub>-BUSiNPs, and PASiO<sub>x</sub>-BUSiNPs, show a 428 similar excitation-emission matrix (see Figure 3E,F) and PL 429 decay times  $\tau$  (see Table 2). These observations strongly 430 indicate that the excitation-emission matrix shape and PL 431 decay times of oxidized SiNPs < 3 nm in size with surface  $\equiv$  432 Si—O—Si≡ structures does not depend on the particle 433 crystalline structure, neither on size nor on further organic 434 capping. The presence of surface ≡Si-O-Si≡ structures 435 leads to an EG reduction in the order of 0.2-0.4 eV with 436 respect to the respective H-passivated TDSiNPs. These 437 observations are in line with theoretical studies predicting 438 that the addition of a single oxygen atom to the surface of 1 nm 439 size H-passivated Si clusters lowers the optical absorption gap 440 by fractions of eV when attached in a bridged configuration 441 (Si—O—Si) but larger impacts on the EG (units of eV) are 442 expected when attached in a double-bonded (>Si=O) 443 configuration.8,10

The excitation and emission spectrum of the oxidized 445 particles shows peaking with an average peak separation of 446 140-180 meV, on the order of the splitting due to zero- 447 phonon line and phonon side bands reported in single molecule 448 experiments of 5 and 6 nm size oxidized crystalline SiNPs 449 embedded in a matrix. Energy spacing close to 150 meV 450 may be attributed to Si—O—Si longitudinal optical (LO) and 451 transverse optical (TO) phonons at the interface. 41 Assuming 452 an electron-phonon interaction, the higher energy of the zero 453 phonon line observed herein (>3.0 eV) might correlate with 454 the smaller silicon core size of the particles in a quantum 455 confinement regime but seems not to support a strong 456 localization of both the electron and the hole at the interface 457 as suggested by the observed independence on particle size and 458 crystallinity. 42 Since effects as the compressive strain exerted by 459 the matrix on embedded nanocrystals may also influence Si- 460 NPs PL, 44 any discussion on the origin of the observed 461 differences requires the comparison with single molecule 462 experiments with the ultrasmall blue emitting SiNPs.

Overall, the obtained results strongly indicate that for small 465 structures where the number of surface atoms is a significant 466 fraction of the total number of atoms (see S.I. Surface Si atoms 467 estimation (Supporting Information)), different adsorbates and 468 atomic arrangements lead to different surface electronic states 469 which influence the SiNPs PL. SS variations of crystalline SiNPs 470 have been largely attributed to energy levels below the 471 conduction band minimum leading to self-trapped excitons 472 localized in the surface. Such deep levels were reported to be 473 introduced by surface states, dangling bonds, and electron-474 phonon interactions. 45 Interestingly, Figure 4A shows an 475 acceptable correlation between the SS and the EG for the 476 different emitting species. These observations and the fact that 477 the same transition is involved in the absorption and emission processes (vide supra) strongly support the contribution of 479 surface states to the energy levels in the gap. It should be noted 480 that species d and h contributing to PA-TDSiNPs and PA-481 BUSiNPs, respectively, are an exception. Chemisorbed N may 482 introduce additional deep levels below the conduction band 483 minimum not affecting the EG. Unfortunately, determination of the precise nature of the contributing species is not possible, and the data is usually open to various interpretations.

Larger SiNPs (>2 nm size) explored in the literature showing green to near-IR PL originated in net quantum confinement effects are also reported to show important modifications in the PL upon changes in their surface chemistry. Therefore, the participation of surface states in SiNPs PL exceeds our observations for small silicon nanoparticles with large surface to volume ratios.

Temperature Dependence of the Emission Quantum 494 Yield. The overall luminescence quantum yield of argon-495 saturated toluene suspensions of the particles diminish with 496 increasing temperature, as shown for MASiO<sub>x</sub>-TD'SiNPs in S.I. 497 Table 1 (Supporting Information). The  $\Phi$  values are fully 498 recovered upon restoring the temperature to the initial values, 499 thus supporting reversible temperature-dependent quenching 500 processes. Plots of  $\ln(\Phi^{-1} - 1)$  vs  $T^{-1}$  show curvature, as 501 expected if two or more deactivation processes with significant 502 activation energies are present. In fact,  $\Phi$  values cannot separate 503 the individual contributions of all the emitting species. 504 Therefore, to understand the temperature effect on PL, a 505 bilinear analysis of the excitation-emission obtained at each 506 temperature in the range from 273 to 330 K was performed for 507 all the particle samples. Such analysis indicates that the intensity 508 but neither the EG nor the SS of each contributing species 509 depends on temperature. Figure 4B shows the decrease of  $I_{\rm T}/$ 510  $I_{273}$  with temperature for several of the contributing species. 511 The ratio of total intensity at a given temperature T with s12 respect to that observed at 273 K  $(I_T/I_{273})$  was used to 513 compensate for all non-temperature-dependent parameters  $_{514}$  affecting  $I_{\mathrm{T}}$  as those of the equipment response and particle 515 concentration. Except for those of species  $d_1 I_T/I_{273K}$  values fall 516 within the same curve, therefore suggesting that the thermally 517 activated quenching does not show a correlation with the particle structure and surface chemistry. Interestingly,  $\tau$  values showed no variation, within the experimental error, in the 200-520 330 K temperature range.

Calcott's model assuming a thermal equilibrium between two s22 excitonic levels of different multiplicity and radiative constant, s23 split by energy  $(\Delta E)$ , is widely used in the literature to interpret the dependence with temperature of the radiative rate constant s25  $k_r$ .  $^{13,14,51-53}$  At very low temperatures, almost all of the excitons s26 are trapped in the lower state, whereas at higher temperatures,

the excitons are in their upper state which is a dominant 527 luminescent center. Reported  $\Delta E$  values are on the order of 3 528 meV.  $^{13,52}$  Considering that  $k_{\rm r}$  is expected not to vary with 529 temperature for T>200 K, decreasing PL intensities with 530 increasing temperature have been attributed to the dominating 531 role of nonradiative recombination.  $^{13,54}$  Two main models were 532 postulated to account for nonradiative thermally activated 533 processes: a normal Arrhenius behavior  $^{13,54}$  and the ionization 534 of the excited state via tunneling through a potential barrier 535 with a Berthelot-type T-dependence.  $^{54,56-58}$  However, considering that our results show that  $(k_r + \sum_i k_{ni}) = \tau^{-1}$  remains 537 constant with temperature,  $k_r$  being itself T-independent, 538 competing nonradiative processes  $\sum_i k_{ni}$  originated in the 539 excitonic level are also expected to be temperature 540 independent. Therefore, the involvement of any of the 541 described mechanisms cannot describe the observed T-542 dependence of the PL intensity.

A static, reversible, thermal quenching of the particles is 544 strongly suggested. Increasing temperatures lead to an 545 increased population of nonemitting particles which might be 546 reverted upon a decrease in temperature. Moreover, since no 547 correlation between the quenching rate and the particle surface 548 chemistry is observed, it is expected that the silicon structure is 549 involved in leading to dark (nonemitting) clusters. These 550 observations are in agreement with those by Diener and co- 551 workers 559 indicating that IR excitation of porous silicon results 552 in a drop in the PL intensity but only with a slight change in the 553 PL lifetime. The authors suggested that IR excitation creates 554 additional dangling bonds or opens additional nonradiative 555 channels leading to an increase of the fraction number of dark 556 crystallites.

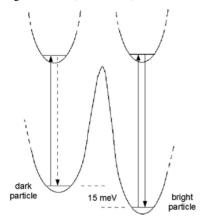
Plots of  $\ln I_{\rm T}$  vs  $T^{-1}$  (see inset in Figure 4B) yield straight 558 lines from which the slopes of the enthalpy change  $\Delta H = +(15\ 559\ \pm\ 1)$  meV of the thermal process leading to the dark particle 560 conformation may be obtained. The observed energy difference 561 between a bright and a dark particle is too small to be assigned 562 to the generation of dangling bonds and are thus suggested to 563 be due to small changes in the structure conformation.

Literature reports on the presence of a dark fraction of 565 particles in quantum dots have been related to blinking 566 dynamics.<sup>60</sup> Reported single molecule level PL studies with Si 567 nanocrystals revealed PL blinking with power-law statistics and 568 "on" and "off" times in the millisecond-second range. 61 Strong 569 disorder effects were reported to provoke the reversible 570 bleaching of SiNPs on a time scale of hours in the dark.<sup>61</sup> A 571 photogeneration mechanism of the dark particles would imply a 572 reduction in the intensity of steady-state PL with the irradiation 573 time. Since no changes in the steady state PL intensity were 574 observed with the illumination time for the particles herein 575 synthesized, dark SiNPs might be assumed in equilibrium with 576 bright particles before illumination. Scheme 3 illustrates the 577 s3 thermal process between dark and bright particles leading to an 578 increased fraction of dark particles as temperature increases. If 579 power-law statistics of blinking also holds for our SiNPs, then it 580 could arise from a multiplicity of dark (or bright) 581 conformations with different energy barriers.

# CONCLUSION

Important challenges in the use of SiNPs as sensors and 584 photosensitizers are the following: their PL dependence on size, 585 crystallinity, and surface structure and chemistry. Also, the low 586 stability of H-terminated SiNPs leads to unwanted surface- 587 oxidized particles unless the synthesis process and surface 588

Scheme 3. Illustration of the Thermal Process Involving Dark and Bright SiNPs (not scaled)



<sup>a</sup>Arrows stand for radiative (solid) and non-radiative (dashed) processes.

589 derivatization are performed under strict oxygen-free con-590 ditions. Our results show that the PL properties of mild surface 591 oxidized 1-2 nm sized particles mainly showing Si—O—Si 592 bridging bonds are independent of the synthesis procedure (BU 593 or TD) and on the further derivatization of the particles surface 594 with organic molecules with different terminal groups. This observation has important consequences for the particles' technological uses as the proper synthesis route may be selected on costs and availability of reactants and equipment. Moreover, 597 even though the main synthetic procedure requires minimiza-599 tion of the dissolved O2, further silanization procedures for 600 organic capping may be conducted under an air atmosphere at 601 room temperature. As a result, biocompatible molecules may be 602 attached to the surface without changes in the PL. The latter 603 properties are important for specific targeting and opsonin 604 association prevention in sensing applications.

#### ASSOCIATED CONTENT

## Supporting Information

TEM, XPS, and FTIR data. This material is available free of charge via the Internet at http://pubs.acs.org.

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617 The authors declare no competing financial interest.

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